Search Notes

Application/Control No.	Applicant(s)/Patent under Reexamination
10/713,415	CHEN ET AL.
Examiner .	Art Unit
Longbit Chai	2131

SEARCHED					
Class	Subclass	Date	Examiner		
	('	hone)			
			,		

INT	INTERFERENCE SEARCHED					
Class	Subclass	Date	Examiner			
						

SEARCH NOTES (INCLUDING SEARCH STRATEGY)				
/	DATE	EXMR		
38 / 277 - 280 713/189-194 726/16-20	3/6/07	Zur		
(text-search) only Bast See Seeven Hitory	2/26/07	Loc		
	·			